

# SAMXON BRAND ALUMINUM ELECTROLYTIC CAPACITORS

# PRODUCT SPECIFICATION 規格書

**CUSTOMER:** DATE:

(客戶):志盛翔 (日期):2017-07-15

CATEGORY (品名) : ALUMINUM ELECTROLYTIC CAPACITORS

DESCRIPTION (型号) : SK 100V150μF(φ10X20)

VERSION (版本) : 01

Customer P/N :

SUPPLIER :

SUPPLI	ER
PREPARED (拟定)	CHECKED (审核)
李婷	刘渭清

CUST	ГОMER
APPROVAL (批准)	SIGNATURE (签名)

# ELECTROLYTIC CAPACITOR SPECIFICATION SK SERIES

		SPECIFICAT	ΓΙΟΝ		ALTERN	ATION HIS	TORY
		SK SERIE	ES		]	RECORDS	
Rev.	Date	Mark	Page	Contents	Purpose	Drafter	Approver
			_		•		

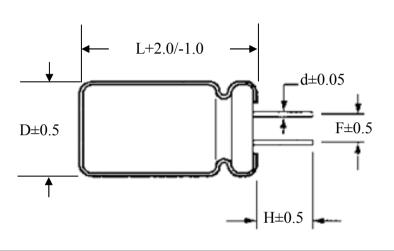
Version	01		Page	1
---------	----	--	------	---

# ELECTROLYTIC CAPACITOR SPECIFICATION SK SERIES

# **SAMXON**

Unit: mm

Table 1 Product Dimensions and Characteristics



Shape Code	D	10
Shape Code	L	20
	F	5.0
CB Type	Н	3.5
	d	0.6

N	SAMXON	WV	Cap.	Con tolonomic	Temp.	tan δ	Leakage	Max Ripple Current	Impedance at 20°C	Load		ension (mm)	l	G1
0.	Part No.	(Vdc)	(μF)	Cap. tolerance	range(°C)	(120Hz, 20℃)	Current (µA,2min)	at 105℃ 100KHz (mA rms)	100kHz (Ωmax)	lifetime (Hrs)	D×L	F	фd	Sleeve
1	ESK157M2AG20CB**P	100	150	-20%~+20%	-40~105	0.08	150	1430	0.084	10000	10X20	5.0	0.6	PET

Version 01	Page 2
------------	--------

**Attachment: Application Guidelines** 

# ELECTROLYTIC CAPACITOR SPECIFICATION SK SERIES

# **SAMXON**

12~15

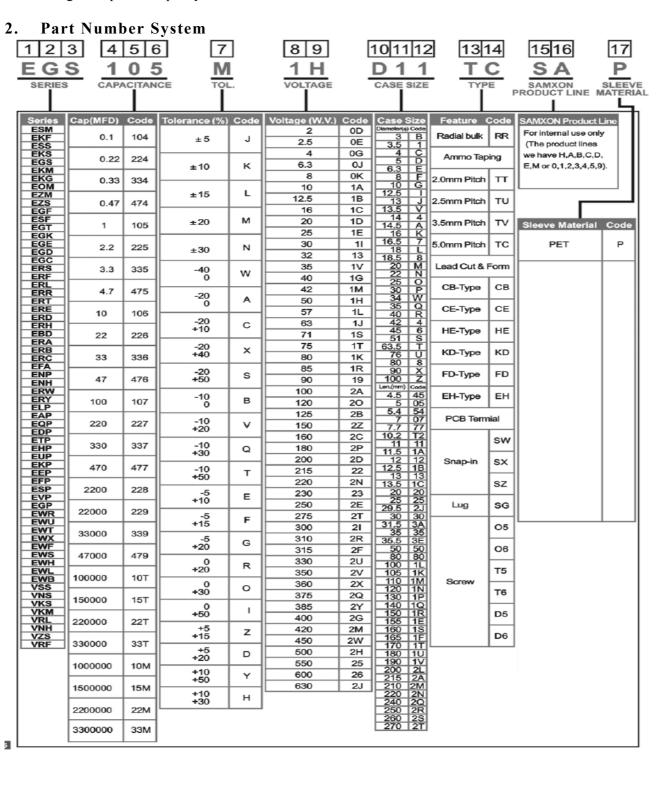
### CONTENTS Sheet 4 1. Application 2. Part Number System 4 3. Construction 5 4. Characteristics 5~10 4.1 Rated voltage & Surge voltage 4.2 Capacitance (Tolerance) 4.3 Leakage current 4.4 $\tan \delta$ 4.5 Terminal strength 4.6 Temperature characteristic 4.7 Load life test 4.8 Shelf life test 4.9 Surge test 4.10 Vibration 4.11 Solderability test 4.12 Resistance to solder heat 4.13 Change of temperature 4.14 Damp heat test 4.15 Vent test 4.16 Maximum permissible (ripple current) 5. List of "Environment-related Substances to be Controlled ('Controlled 11 Substances')"

## ELECTROLYTIC CAPACITOR SPECIFICATION SK SERIES

# **SAMXON**

### 1. Application

This specification applies to polar Aluminum electrolytic capacitor (foil type) used in electronic equipment. Designed capacitor's quality meets IEC60384.

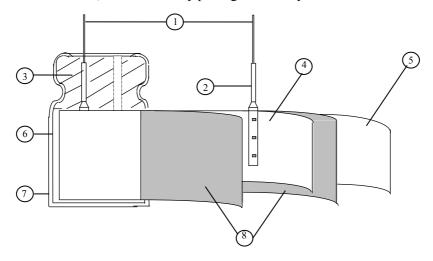


# ELECTROLYTIC CAPACITOR SPECIFICATION SK SERIES

# **SAMXON**

#### 3. Construction

Single ended type to be produced to fix the terminals to anode and cathode foil, and wind together with paper, and then wound element to be impregnated with electrolyte will be enclosed in an aluminum case. Finally sealed up tightly with end seal rubber, then finished by putting on the vinyl sleeve.



	Component	Material
1	Lead line	Tinned CP wire (Pb Free)
2	Terminal	Aluminum wire
3	Sealing Material	Rubber
4	Al-Foil (+)	Formed aluminum foil
5	Al-Foil (-)	Etched aluminum foil or formed aluminum foil
6	Case	Aluminum case
7	Sleeve	PET
8	Separator	Electrolyte paper

#### 4. Characteristics

#### Standard atmospheric conditions

Unless otherwise specified, the standard range of atmospheric conditions for making measurements and tests are as follows:

Ambient temperature :15°C to 35°C
Relative humidity : 45% to 85%
Air Pressure : 86kPa to 106kPa

If there is any doubt about the results, measurement shall be made within the following conditions:

Ambient temperature :  $20^{\circ}\text{C} \pm 2^{\circ}\text{C}$ Relative humidity : 60% to 70%Air Pressure : 86kPa to 106kPa

#### Operating temperature range

The ambient temperature range at which the capacitor can be operated continuously at rated voltage See table 1 temperature range.

As to the detailed information, please refer to table 2.

Version	01		Page	5
---------	----	--	------	---

# ELECTROLYTIC CAPACITOR SPECIFICATION SK SERIES

	ITEM				PERFO	RMANC	CE			
	Rated voltage									
	(WV)	WV (V.DC)	6.3	10	16	25	35	50	63	100
4.1		SV (V.DC)	8	13	20	32	44	63	79	125
	Surge voltage (SV)									
4.2	Nominal capacitance (Tolerance)	<b>Condition&gt;</b> Measuring F Measuring Vo Measuring T <b>Criteria&gt;</b> Shall be with	requency oltage emperat	: N ure : 20	)±2℃	than 0.5V				
4.3	Leakage current	Condition> Connecting to minutes, and  Criteria> Refer to Table	then, me		_		istor (1	kΩ ±10	Ω) in s	eries for
4.4	tan δ	<condition> See 4.2, Norr  <criteria> Refer to Table</criteria></condition>	n Capac	itance, fo	or measui	ring frequ	iency, vo	oltage and	d tempera	ature.
		Condition> Tensile Street Street the conditions Street	ength of apacitor rength of pacitor,	f, applied f Termina applied f	force to als. Force to b then ber	ent the te	rminal (1	l∼4 mm f original <sub>l</sub>	from the position	rubber) f
4.5	Terminal	Diamet	er of lea	d wire		ile force (kgf)	IN	Bending (kg		
-	strength		nm and			5 (0.51)		2.5 (	0.25)	
		Over 0.	5mm to	0.8mm	1	0 (1.0)		5 (0	.51)	
		<criteri No notic</criteri 		nanges sh	all be for	ınd, no b	reakage	or loosen	ess at the	e termina

Version	01		Page	6
---------	----	--	------	---

# ELECTROLYTIC CAPACITOR SPECIFICATION SK SERIES

		<cond< th=""><th>dition&gt;</th><th></th><th></th><th></th><th>. 1</th><th></th><th>m.</th><th></th><th></th></cond<>	dition>				. 1		m.		
			STEP	Testing		erature(°C			Time		
		_	1		$20\pm 2$		_	e to reach			
			2	-4	40(-25)			e to reach		•	
			3		$20\pm 2$	2	Tim	e to reach	thermal ed	quilibriu	m
			4		$105 \pm 1$	2		e to reach			
			5		$20 \pm 2$	2	Tim	e to reach	thermal ed	quilibriu	m
	Temperature	<crite< td=""><td></td><td></td><td></td><td></td><td></td><td></td><td></td><td></td><td></td></crite<>									
	characteristi	a.				e limit of					
4.6	cs			akage cui	rrent me	easured s	hall not	more that	n 8 times	of its sp	pecified
		1	value.	<i>5</i> , °	1 11 1	:4: 4	11 14	CT. 4.4			
			•					f Item 4.4	C.1 . C	. 11	. 11
								ed the value	1	1	1
			ng Volta		6.3	10	16	25	35	50	100
		<b>Z-</b> 2.	5°C/Z+2	0 C	2	2	2	2	2	2	2
		Capacit	tance, tar	$1 \delta$ , and i	mpedan	nce shall b	e measi	ared at 120	)Hz.		
				,	•						
		<conditi< td=""><td>ion&gt;</td><td></td><td></td><td></td><td></td><td></td><td></td><td></td><td></td></conditi<>	ion>								
			Aggardin	, IEC							
			Accordin	ng to IEC	60384-4	4No.4.13	method	s, The cap	acitor is st	tored at a	ı
			at a temp	perature o	of 105°C	$C \pm 2$ with	nDC bia	s voltage p	olus the ra	ted ripple	e currer
			at a temp for Table	perature of e1. (The	of 105°C sum of	$C\pm 2$ with DC and r	DC bia ipple pe	s voltage p ak voltage	olus the ra e shall not	ted ripple exceed t	e currer the rate
		,	at a temp for Table working	perature of e1. (The voltage)	of 105°C sum of Then th	$C\pm 2$ with DC and reproduce	DC bia ipple pe	s voltage p	olus the ra e shall not	ted ripple exceed t	e currenthe the rate
	Load	t	at a temp for Table working time at at	perature of e1. (The voltage) tmospher	of 105°C sum of Then the ic condi	$C \pm 2$ with DC and rone productions.	DC bia ipple pe t should	s voltage pak voltage be tested	olus the ra e shall not	ted ripple exceed t	e currenthe the rate
4.7	life	t	at a temp for Table working time at at The resu	perature of e1. (The voltage) tmospher lt should	of 105°C sum of Then the ic condi	$C\pm 2$ with DC and reproduce	DC bia ipple pe t should	s voltage pak voltage be tested	olus the ra e shall not	ted ripple exceed t	e currenthe the rate
4.7		t t	at a temptor Table working time at at The resure.	perature of e1. (The voltage) tmospheralt should a>	of 105°C sum of Then the ic condi- meet the	$C \pm 2$ with DC and reproductions.	DC bia ipple pe t should ng table	s voltage pak voltage be tested	olus the rate shall not after 16	ted ripple exceed t	e currenthe the rate
4.7	life	t t	at a temp for Table working time at at The resu Criteri The char	perature of el. (The voltage) tmospher. It should a>	of 105°C sum of Then the ic condi meet the shall m	$C \pm 2$ with DC and reproductions.  The following meet the following states are the following s	DC bia ipple pe t should ng table:	s voltage pak voltage be tested	olus the rate shall not after 16 l	ted ripple exceed t	e currenthe the rate
4.7	life	t t	at a temp for Table working time at at The resu <b>Criteri</b> The char Leakag	perature of el. (The voltage) tmospher lt should a> racteristic e current	of 105°C sum of Then the ic condi- meet the shall m	DC and reproductions.  The following the fol	DC bia ipple pe t should ng table: illowing 4.3 shal	s voltage pak voltage be tested	olus the rate shall not after 16 dents.	ted ripple exceed thours rec	e current the rate covering
4.7	life	t t	at a temp for Table working time at at The resu <b><criteri< b=""> The char Leakag Capacit</criteri<></b>	perature of el. (The voltage) tmospher. It should a>	of 105°C sum of Then the condition meet the shall manage	C ±2 with DC and reproductions. The following the following within ±2 within	n DC bia ipple pe t should ng table: allowing 4.3 shal 25% of	s voltage pak voltage pak voltage be tested requiremental be satisfic initial variations.	e shall not after 16 deepents.	ted ripple exceed thours reconstruction	e current the rate covering
4.7	life	t t	at a temp for Table working time at at The resu <b><criteri< b=""> The char Leakag Capacit tan 8</criteri<></b>	perature of el. (The voltage) tmospher lt should a> racteristic e current tance Cha	of 105°C sum of Then the condition meet the shall manage	C ±2 with DC and reproductions. The following the following within distributions are the following within distributions.	a DC bia ipple pe t should ng table dllowing 4.3 shal 25% of e than 20	s voltage pak voltage pak voltage be tested requirement be satisfif initial value of the	eshall not after 16 dents.	ted ripplo exceed thours recovery the cours recovery the course of the course o	e current the rate covering
4.7	life	t i	at a temp for Table working time at at The resu < <b>Criteri</b> The char Leakag Capacit tan δ	perature of el. (The voltage) tmospher lt should a> racteristic e current tance Cha	of 105°C sum of Then the condition meet the shall manage	C ±2 with DC and reproductions. The following the following within distributions are the following within distributions.	a DC bia ipple pe t should ng table dllowing 4.3 shal 25% of e than 20	s voltage pak voltage pak voltage be tested requiremental be satisfic initial variations.	eshall not after 16 dents.	ted ripplo exceed thours recovery the cours recovery the course of the course o	e current the rate covering
4.7	life	<condition< td=""><td>at a temp for Table working time at at The resu <criteri The char Leakag Capacit tan 8 Appear</criteri </td><td>perature of el. (The voltage) tmospher lt should a&gt; racteristic e current tance Cha</td><td>of 105°C sum of Then the condition meet the shall mange</td><td>E ±2 with DC and r ne productions. The following the following the following within ± Not more There shapes and the following th</td><td>a DC bia ipple pe t should ng table: allowing 4.3 shal 25% of than 20 hall be no</td><td>s voltage pak voltage pak voltage per le tested requirement le be satisfif initial var 20% of the poleakage</td><td>ents.  ed  alue(6.3,10  especified  of electrol</td><td>ted ripplo exceed thours reconstruction of the construction of th</td><td>e currer the rate covering the same same same same same same same sam</td></condition<>	at a temp for Table working time at at The resu <criteri The char Leakag Capacit tan 8 Appear</criteri 	perature of el. (The voltage) tmospher lt should a> racteristic e current tance Cha	of 105°C sum of Then the condition meet the shall mange	E ±2 with DC and r ne productions. The following the following the following within ± Not more There shapes and the following th	a DC bia ipple pe t should ng table: allowing 4.3 shal 25% of than 20 hall be no	s voltage pak voltage pak voltage per le tested requirement le be satisfif initial var 20% of the poleakage	ents.  ed  alue(6.3,10  especified  of electrol	ted ripplo exceed thours reconstruction of the construction of th	e currer the rate covering the same same same same same same same sam
4.7	life	<condition< td=""><td>at a temp for Table working time at at The resu &lt;<b>Criteri</b> The char Leakag Capacit tan 8 Appear on&gt;</td><td>perature of el. (The voltage) tmospher lt should a&gt; racteristic e current tance Characteristic rance</td><td>of 105°C sum of Then the condition meet the shall mange</td><td>E ±2 with DC and r ne productions. The following the following the following within ± Not more There shapes and the following th</td><td>a DC bia ipple pe t should ng table: allowing 4.3 shal 25% of than 20 hall be no</td><td>s voltage pak voltage pak voltage be tested requirement be satisfif initial value of the</td><td>ents.  ed  alue(6.3,10  especified  of electrol</td><td>ted ripplo exceed thours reconstruction of the construction of th</td><td>e currer the rate covering the same same same same same same same sam</td></condition<>	at a temp for Table working time at at The resu < <b>Criteri</b> The char Leakag Capacit tan 8 Appear on>	perature of el. (The voltage) tmospher lt should a> racteristic e current tance Characteristic rance	of 105°C sum of Then the condition meet the shall mange	E ±2 with DC and r ne productions. The following the following the following within ± Not more There shapes and the following th	a DC bia ipple pe t should ng table: allowing 4.3 shal 25% of than 20 hall be no	s voltage pak voltage pak voltage be tested requirement be satisfif initial value of the	ents.  ed  alue(6.3,10  especified  of electrol	ted ripplo exceed thours reconstruction of the construction of th	e currer the rate covering the same same same same same same same sam
4.7	life	<condition< td=""><td>at a temp for Table working time at at The resu &lt;<b>Criteri</b> The char Leakag Capacit tan δ Appear on&gt; he capaci</td><td>perature of e1. (The voltage) tmospher lt should a&gt; acteristic e current tance Chamance</td><td>of 105°C sum of Then the condition meet the shall manage when store hours.</td><td>C ± 2 with DC and reproductions. The following the followi</td><td>a DC bia ipple pe t should ng table: dlowing 4.3 shal 25% of e than 20 all be no</td><td>s voltage pak voltage pak voltage per sequirement be satisfif initial various of the per sequirement of leakage sequirement per sequirement be satisfied by the per sequirement of the</td><td>ents.  ents.  en</td><td>exceed the exceed the hours reconstruction of the exceed the exceeding the</td><td>e currer the rate covering 30%)</td></condition<>	at a temp for Table working time at at The resu < <b>Criteri</b> The char Leakag Capacit tan δ Appear on> he capaci	perature of e1. (The voltage) tmospher lt should a> acteristic e current tance Chamance	of 105°C sum of Then the condition meet the shall manage when store hours.	C ± 2 with DC and reproductions. The following the followi	a DC bia ipple pe t should ng table: dlowing 4.3 shal 25% of e than 20 all be no	s voltage pak voltage pak voltage per sequirement be satisfif initial various of the per sequirement of leakage sequirement per sequirement be satisfied by the per sequirement of the	ents.  en	exceed the exceed the hours reconstruction of the exceed the exceeding the	e currer the rate covering 30%)
4.7	life	<condition 2'="" f<="" t1="" td=""><td>at a temp for Table working time at at The resu <criteri The char Leakag Capacit tan 8 Appear on&gt; he capac: Collowing</criteri </td><td>perature of el. (The voltage) tmospher. It should a&gt; racteristic e current tance Chamber ance itors are to 000+48/0 g this peri</td><td>of 105°C sum of Then the condition meet the shall manage when store hours.</td><td>E ± 2 with DC and reproductions. The following the followi</td><td>a DC bia ipple pet t should ng table:  allowing 4.3 shale: 25% of than 20 and voltage shall be no voltage.</td><td>s voltage pak voltage pak voltage pak voltage per per per per per per per per per pe</td><td>ents.  deliced after 16 deliced after 16</td><td>exceed the exceed the hours reconstruction of the exceed the exceeding the</td><td>e current the rate covering 30%)</td></condition>	at a temp for Table working time at at The resu <criteri The char Leakag Capacit tan 8 Appear on&gt; he capac: Collowing</criteri 	perature of el. (The voltage) tmospher. It should a> racteristic e current tance Chamber ance itors are to 000+48/0 g this peri	of 105°C sum of Then the condition meet the shall manage when store hours.	E ± 2 with DC and reproductions. The following the followi	a DC bia ipple pet t should ng table:  allowing 4.3 shale: 25% of than 20 and voltage shall be no voltage.	s voltage pak voltage pak voltage pak voltage per per per per per per per per per pe	ents.  deliced after 16	exceed the exceed the hours reconstruction of the exceed the exceeding the	e current the rate covering 30%)
4.7	life test	<condition 2="" b<="" f="" td="" ti=""><td>at a temp for Table working time at at The resu <criteri The char Leakag Capacit tan 8 Appear on&gt; he capace °C for 10 following e allowed</criteri </td><td>perature of el. (The voltage) tmospher lt should a&gt; racteristic e current tance Charance ditors are to 200+48/0 g this perid to stabi</td><td>of 105°C sum of Then the condition meet the shall manage when store hours. od the colized at</td><td>E ± 2 with DC and reproductions. The following the followi</td><td>a DC bia ipple pe t should ng table: allowing 4.3 shal 25% of than 20 all be no no voltage shall be apperature</td><td>requirement be satisfication of the poleakage applied the removed the for 4~8 h</td><td>ents.  ed  alue(6.3,10  e specified  of electrol  at a temp  from the  nours.</td><td>ov:≤±: value. yte.  test chan</td><td>e current the rate covering 30%)</td></condition>	at a temp for Table working time at at The resu <criteri The char Leakag Capacit tan 8 Appear on&gt; he capace °C for 10 following e allowed</criteri 	perature of el. (The voltage) tmospher lt should a> racteristic e current tance Charance ditors are to 200+48/0 g this perid to stabi	of 105°C sum of Then the condition meet the shall manage when store hours. od the colized at	E ± 2 with DC and reproductions. The following the followi	a DC bia ipple pe t should ng table: allowing 4.3 shal 25% of than 20 all be no no voltage shall be apperature	requirement be satisfication of the poleakage applied the removed the for 4~8 h	ents.  ed  alue(6.3,10  e specified  of electrol  at a temp  from the  nours.	ov:≤±: value. yte.  test chan	e current the rate covering 30%)
	life test  Shelf	<condition 2'="" b="" f="" n<="" td="" ti=""><td>at a temp for Table working time at at at The resu   Criteri The char Leakag Capacit tan &amp; Appear on&gt; the capace °C for 10 Collowing the allowed lext they</td><td>perature of e1. (The voltage) tmospher lt should a&gt; racteristic e current tance Characteristic ance ditors are to 200+48/0 g this period to stabil shall be</td><td>of 105°C sum of Then the condition meet the shall mange when store hours, od the collized at connection of the connection meet the shall mange when store hours.</td><td>E ± 2 with DC and reproductions. The following seet the following seet</td><td>a DC bia ipple pe t should ng table: allowing 4.3 shale: 25% of than 20 all be no than voltage shall be apperature eries lim</td><td>s voltage pak voltage pak voltage pak voltage per per per per per per per per per pe</td><td>ents.  ents.  ents.  ents.  ents.  ents.  ents.  fed  elue(6.3,10)  at a temp  from the frours.  estor(1k±1)</td><td>exceed the exceed the hours recovered to hours re</td><td>e current the rate covering 30%) of 105 ± and and tith D.C.</td></condition>	at a temp for Table working time at at at The resu Criteri The char Leakag Capacit tan & Appear on> the capace °C for 10 Collowing the allowed lext they	perature of e1. (The voltage) tmospher lt should a> racteristic e current tance Characteristic ance ditors are to 200+48/0 g this period to stabil shall be	of 105°C sum of Then the condition meet the shall mange when store hours, od the collized at connection of the connection meet the shall mange when store hours.	E ± 2 with DC and reproductions. The following seet	a DC bia ipple pe t should ng table: allowing 4.3 shale: 25% of than 20 all be no than voltage shall be apperature eries lim	s voltage pak voltage pak voltage pak voltage per per per per per per per per per pe	ents.  ents.  ents.  ents.  ents.  ents.  ents.  fed  elue(6.3,10)  at a temp  from the frours.  estor(1k±1)	exceed the exceed the hours recovered to hours re	e current the rate covering 30%) of 105 ± and and tith D.C.
	life test  Shelf life	<condition 2'="" b="" f="" n="" t1="" ta<="" td=""><td>at a temp for Table working time at at The resu &lt;<b>Criteri</b> The char Leakag Capacit tan δ Appear on&gt; he capac °C for 10 following we allowed sext they</td><td>perature of e1. (The voltage) tmospher lt should a&gt; racteristic e current tance Characteristic ance ditors are to 200+48/0 g this period to stabil shall be</td><td>of 105°C sum of Then the condition meet the shall manage when store hours, od the colized at connected for 3</td><td>E ± 2 with DC and reproductions. The following the followi</td><td>a DC bia ipple pe t should ng table: allowing 4.3 shale: 25% of than 20 all be no than voltage shall be apperature eries lim</td><td>requirement be satisfication of the colleakage o</td><td>ents.  ents.  ents.  ents.  ents.  ents.  ents.  fed  elue(6.3,10)  at a temp  from the frours.  estor(1k±1)</td><td>exceed the exceed the hours recovered to hours re</td><td>e current the rate covering 30%) of 105± and and the D.C.</td></condition>	at a temp for Table working time at at The resu < <b>Criteri</b> The char Leakag Capacit tan δ Appear on> he capac °C for 10 following we allowed sext they	perature of e1. (The voltage) tmospher lt should a> racteristic e current tance Characteristic ance ditors are to 200+48/0 g this period to stabil shall be	of 105°C sum of Then the condition meet the shall manage when store hours, od the colized at connected for 3	E ± 2 with DC and reproductions. The following the followi	a DC bia ipple pe t should ng table: allowing 4.3 shale: 25% of than 20 all be no than voltage shall be apperature eries lim	requirement be satisfication of the colleakage o	ents.  ents.  ents.  ents.  ents.  ents.  ents.  fed  elue(6.3,10)  at a temp  from the frours.  estor(1k±1)	exceed the exceed the hours recovered to hours re	e current the rate covering 30%) of 105± and and the D.C.
	life test  Shelf life	<condition 2'="" b="" f="" n="" t1="" ta<="" td=""><td>at a temp for Table working time at at The resu &lt;<b>Criteri</b> The char Leakag Capacit tan δ Appear on&gt; he capac °C for 10 following we allowed sext they</td><td>perature of e1. (The voltage) tmospher lt should a&gt; acteristic e current tance Chamber and the control of the period to stability shall be age applications.</td><td>of 105°C sum of Then the condition meet the shall manage when store hours, od the colized at connected for 3</td><td>E ± 2 with DC and reproductions. The following the followi</td><td>a DC bia ipple pe t should ng table: allowing 4.3 shale: 25% of than 20 all be no than voltage shall be apperature eries lim</td><td>requirement be satisfication of the colleakage o</td><td>ents.  ents.  ents.  ents.  ents.  ents.  ents.  fed  elue(6.3,10)  at a temp  from the frours.  estor(1k±1)</td><td>exceed the exceed the hours recovered to hours re</td><td>e current the rate covering 30%) of 105± and and the D.C.</td></condition>	at a temp for Table working time at at The resu < <b>Criteri</b> The char Leakag Capacit tan δ Appear on> he capac °C for 10 following we allowed sext they	perature of e1. (The voltage) tmospher lt should a> acteristic e current tance Chamber and the control of the period to stability shall be age applications.	of 105°C sum of Then the condition meet the shall manage when store hours, od the colized at connected for 3	E ± 2 with DC and reproductions. The following the followi	a DC bia ipple pe t should ng table: allowing 4.3 shale: 25% of than 20 all be no than voltage shall be apperature eries lim	requirement be satisfication of the colleakage o	ents.  ents.  ents.  ents.  ents.  ents.  ents.  fed  elue(6.3,10)  at a temp  from the frours.  estor(1k±1)	exceed the exceed the hours recovered to hours re	e current the rate covering 30%) of 105± and and the D.C.

Version	01		Page	7	l
---------	----	--	------	---	---

# ELECTROLYTIC CAPACITOR SPECIFICATION SK SERIES

		<criteria></criteria>	
		The characteristic shall r	neet the following requirements.
		Leakage current	Value in 4.3 shall be satisfied
4.0	Shelf	Capacitance Change	Within $\pm 25\%$ of initial value(6.3,10V: $\leq \pm 30\%$ )
4.8	life	tan δ	Not more than 200% of the specified value.
	test	Appearance	There shall be no leakage of electrolyte.
			e stored more than 1 year, the leakage current may
		-	we through about 1 k $\Omega$ resistor, if necessary.
		<condition></condition>	, c
			ne capacitor connected with a $(100 \pm 50)/C_R (k\Omega)$ resistor.
		The capacitor shall be submi	tted to 1000 cycles, each consisting of charge of $30 \pm 5s$ ,
		followed discharge of 5 min	30s.
		The test temperature shall be	
		C <sub>R</sub> : Nominal Capacitance (	μ F)
	Surge	<criteria></criteria>	
4.9	test	Leakage current	Not more than the specified value.
		Capacitance Change	Within $\pm 15\%$ of initial value.
		tan δ	Not more than the specified value.
		Appearance	There shall be no leakage of electrolyte.
		Attention:	
			age at abnormal situation only. It is not applicable to such
		over voltage as often applied	1.
		perpendicular directions. Vibration frequency ra Peak to peak amplitud Sweep rate Mounting method:	e : 1.5mm : $10\text{Hz} \sim 55\text{Hz} \sim 10\text{Hz}$ in about 1 minute greater than 12.5mm or longer than 25mm must be fixed Within 30°
4.10	Vibration test		
		<criteria></criteria>	To be soldered
		After the test, the following	
		I Inner construction	No intermittent contacts, open or short circuiting.
			No damage of tab terminals or electrodes.  No mechanical damage in terminal. No leakage
			of electrolyte or swelling of the case.
			The markings shall be legible.
			5

Version	01		Page	8
---------	----	--	------	---

# ELECTROLYTIC CAPACITOR SPECIFICATION SK SERIES

		<condition></condition>					
		The capacitor shall be tes	ted under	the following	conditions:		
		Soldering temperature		: 245±3°C			
	G 11 177	Dipping depth		: 2mm			
4.11	Solderability	Dipping speed		: 25±2.5mm	/s		
	test	Dipping time		: 3±0.5s			
		<criteria></criteria>					
		Coating quality		A minimun immersed	n of 95% of the surface	ce being	
		<condition></condition>					
		Terminals of the capac	citor shall	be immersed i	nto solder bath at		
		$260\pm5$ °C for $10\pm1$ sec	conds or 4	00±10℃for3	$^{+1}_{0}$ seconds to 1.5~2.0	Omm from the	
		body of capacitor.			-0		
		Then the capacitor sha	ıll be left u	nder the norma	al temperature and no	rmal humidity	
4.10	Resistance to	for 1~2 hours before r					
4.12	solder heat	<criteria></criteria>					
	test	Leakage current	N	ot more than the	he specified value.		
		Capacitance Change	V	Vithin ±10% o	of initial value.		
		tan 8		ot more than the	he specified value.		
		Appearance	Т	here shall be n	o leakage of electroly	yte.	
		<condition></condition>					
		Temperature Cycle:Acco				or shall be	
		placed in an oven, the condition according as below:  Temperature  Time				1	
			e	Time			
		(1)+20°C			≪3 Minutes		
	Change of	(2)Rated low temper	ature (-40	°C) (-25°C)	$30\pm2$ Minutes		
4.13	temperature	(3)Rated high tempe	rature (+1	05°C)	$30\pm2$ Minutes		
	test	(1) to $(3)=1$ cycle, to	tal 5 cycle	•			
		<criteria></criteria>				·	
		The characteristic shall m				_	
		Leakage current			pecified value.		
		tan δ			pecified value.		
		Appearance	Ther	e shall be no le	akage of electrolyte.		
		<condition></condition>					
		Humidity Test:					
		According to IEC60384-	4No.4.12	methods, capac	citor shall be exposed	1 for $500\pm8$	
		hours in an atmosphere o	f 90~95%	R H .at $40\pm2^\circ$	°C, the characteristic	change shall	
		meet the following requirement.					
		<criteria></criteria>				_	
4.14	Damp heat	Leakage current		re than the spec		_	
-1.17	test	Capacitance Change		$\pm 20\%$ of initi		_	
		tan $\delta$			of the specified value.		
		Appearance	There sl	nall be no leaka	age of electrolyte.	_	

Version	01		Page	9
---------	----	--	------	---

# ELECTROLYTIC CAPACITOR SPECIFICATION SK SERIES

4.15	Vent test	22.4 or less	ith its polarible is applerrent (A)	rity reversed ied.	l to a DC p	ower source.	Then
		Condition> The maximum permissible right at 120Hz and can be applied Table-1 The combined value of D.C rated voltage and shall not respect to the conficient of the confici	l at maximi	um operatin	g temperatı	ıre	ed th
	Maximum permissible	Cap. (µ F)	0.50	0.73	0.92	1.00	
4.16	•						
	current)						
4.16	permissible (ripple	33~270 330~680 820~1800 2200~8200	0.50 0.55 0.60 0.70	0.73 0.77 0.80 0.85	0.92 0.94 0.96 0.98	1.00 1.00 1.00 1.00	

Version	01		Page	10	
---------	----	--	------	----	--

# ELECTROLYTIC CAPACITOR SPECIFICATION SK SERIES

# **SAMXON**

5. It refers to the latest document of "Environment-related Substances standard" (WI-HSPM-QA-072).

	Substances
	Cadmium and cadmium compounds
Heavy metals	Lead and lead compounds
Ticavy metais	Mercury and mercury compounds
	Hexavalent chromium compounds
	Polychlorinated biphenyls (PCB)
Chloinated	Polychlorinated naphthalenes (PCN)
organic	Polychlorinated terphenyls (PCT)
compounds	Short-chain chlorinated paraffins(SCCP)
	Other chlorinated organic compounds
D : 1	Polybrominated biphenyls (PBB)
Brominated	Polybrominated diphenylethers(PBDE) (including
organic	decabromodiphenyl ether[DecaBDE])
compounds	Other brominated organic compounds
Tributyltin comp	ounds(TBT)
Triphenyltin com	apounds(TPT)
Asbestos	
Specific azo com	pounds
Formaldehyde	
Beryllium oxide	
Beryllium copp	er
Specific phthalat	es (DEHP,DBP,BBP,DINP,DIDP,DNOP,DNHP)
Hydrofluorocarb	on (HFC), Perfluorocarbon (PFC)
Perfluorooctane :	sulfonates (PFOS)
Specific Benzotr	iazole

Version	01		Page	11
---------	----	--	------	----

### ELECTROLYTIC CAPACITOR SPECIFICATION SK SERIES

# SAMXON

#### **Attachment: Application Guidelines**

#### 1.Circuit Design

#### 1.1 Operating Temperature and Frequency

Electrolytic capacitor electrical parameters are normally specified at 20°C temperature and 120Hz frequency. These parameters vary with changes in temperature and frequency. Circuit designers should take these changes into consideration.

- (1) Effects of operating temperature on electrical parameters
  - a) At higher temperatures, leakage current and capacitance increase while equivalent series resistance (ESR) decreases.
  - b) At lower temperatures, leakage current and capacitance decrease while equivalent series resistance (ESR) increases.
- (2) Effects of frequency on electrical parameters
  - a) At higher frequencies capacitance and impedance decrease while tanδ increases.
  - b) At lower frequencies, ripple current generated heat will rise due to an increase in equivalent series resistance (ESR).

#### 1.2 Operating Temperature and Life Expectancy

See the file: Life calculation of aluminum electrolytic capacitor

#### 1.3 Common Application Conditions to Avoid

The following misapplication load conditions will cause rapid deterioration to capacitor electrical parameters. In addition, rapid heating and gas generation within the capacitor can occur causing the pressure relief vent to operate and resultant leakage of electrolyte. Under Leaking electrolyte is combustible and electrically conductive.

#### (1) Reverse Voltage

DC capacitors have polarity. Verify correct polarity before insertion. For circuits with changing or uncertain polarity, use DC bipolar capacitors. DC bipolar capacitors are not suitable for use in AC circuits.

#### (2) Charge / Discharge Applications

Standard capacitors are not suitable for use in repeating charge / discharge applications. For charge / discharge applications consult us and advise actual conditions.

#### (3) Over voltage

Do not apply voltages exceeding the maximum specified rated voltage. Voltages up to the surge voltage rating are acceptable for short periods of time. Ensure that the sum of the DC voltage and the superimposed AC ripple voltage does not exceed the rated voltage.

#### (4) Ripple Current

Do not apply ripple currents exceeding the maximum specified value. For high ripple current applications, use a capacitor designed for high ripple currents or contact us with your requirements. Ensure that allowable ripple currents superimposed on low DC bias voltages do not cause reverse voltage conditions.

#### 1.4 Using Two or More Capacitors in Series or Parallel

#### (1) Capacitors Connected in Parallel

The circuit resistance can closely approximate the series resistance of the capacitor causing an imbalance of ripple current loads within the capacitors. Careful design of wiring methods can minimize the possibility of excessive ripple currents applied to a capacitor.

#### (2) Capacitors Connected in Series

Normal DC leakage current differences among capacitors can cause voltage imbalances. The use of voltage divider shunt resistors with consideration to leakage current can prevent capacitor voltage imbalances.

#### 1.5 Capacitor Mounting Considerations

#### (1) Double Sided Circuit Boards

Avoid wiring pattern runs, which pass between the mounted capacitor and the circuit board.

When dipping into a solder bath, excess solder may collect under the capacitor by capillary action and short circuit the anode and cathode terminals.

#### (2) Circuit Board Hole Positioning

The vinyl sleeve of the capacitor can be damaged if solder passes through a lead hole for subsequently processed parts. Special care when locating hole positions in proximity to capacitors is recommended.

#### (3)Circuit Board Hole Spacing

The circuit board holes spacing should match the capacitor lead wire spacing within the specified tolerances. Incorrect spacing can cause excessive lead wire stress during the insertion process. This may result in premature capacitor failure due to short or open circuit, increased leakage current, or electrolyte leakage.

#### (4) Clearance for Case Mounted Pressure Relief vents

Capacitors with case mounted pressure relief vents require sufficient clearance to allow for proper vent operation. The minimum clearances are dependent on capacitor diameters as proper vent operation. The minimum clearances are dependent on capacitor diameters as follows.

φ6.3~φ16mm:2mm minimum, φ18~φ35mm:3mm minimum, φ40mm or greater:5mm minimum.

#### (5) Clearance for Seal Mounted Pressure Relief Vents

A hole in the circuit board directly under the seal vent location is required to allow proper release of pressure.

Version 01		Page	12
------------	--	------	----

### ELECTROLYTIC CAPACITOR SPECIFICATION SK SERIES

# SAMXON

#### (6) Wiring Near the Pressure Relief Vent

Avoid locating high voltage or high current wiring or circuit board paths above the pressure relief vent. Flammable, high temperature gas exceeding 100°C may be released which could dissolve the wire insulation and ignite.

(7) Circuit Board patterns Under the Capacitor

Avoid circuit board runs under the capacitor as electrolyte leakage could cause an electrical short.

(8) Screw Terminal Capacitor Mounting

Do not orient the capacitor with the screw terminal side of the capacitor facing downwards.

Tighten the terminal and mounting bracket screws within the torque range specified in the specification.

#### 1.6 Electrical Isolation of the Capacitor

Completely isolate the capacitor as follows.

- (1) Between the cathode and the case (except for axially leaded B types) and between the anode terminal and other circuit paths
- (2) Between the extra mounting terminals (on T types) and the anode terminal, cathode terminal, and other circuit paths.
- 1.7 The Product endurance should take the sample as the standard.
- 1.8 If conduct the load or shelf life test, must be collect date code within 6 months products of sampling.

#### 1.9 Capacitor Sleeve

The vinyl sleeve or laminate coating is intended for marking and identification purposes and is not meant to electrically insulate the capacitor.

The sleeve may split or crack if immersed into solvents such as toluene or xylene, and then exposed to high temperatures.

#### CAUTION!

Always consider safety when designing equipment and circuits. Plan for worst case failure modes such as short circuits and open circuits which could occur during use.

- (1) Provide protection circuits and protection devices to allow safe failure modes.
- (2) Design redundant or secondary circuits where possible to assure continued operation in case of main circuit failure.

#### 2. Capacitor Handling Techniques

- 2.1 Considerations Before Using
- (1) Capacitors have a finite life. Do not reuse or recycle capacitors from used equipment.
- (2) Transient recovery voltage may be generated in the capacitor due to dielectric absorption. If required, this voltage can be discharged with a resistor with a value of about 1kΩ.
- (3) Capacitors stored for long periods of time may exhibit an increase in leakage current. This can be corrected by gradually applying rated voltage in series with a resistor of approximately  $1k\Omega$ .
- (4) If capacitors are dropped, they can be damaged mechanically or electrically. Avoid using dropped capacitors.
- (5) Dented or crushed capacitors should not be used. The seal integrity can be compromised and loss of electrolyte / shortened life can result.

#### 2.2 Capacitor Insertion

- (1) Verify the correct capacitance and rated voltage of the capacitor.
- (2) Verify the correct polarity of the capacitor before inserting.
- (3) Verify the correct hole spacing before insertion (land pattern size on chip type) to avoid stress on the terminals.
- (4) Ensure that the auto insertion equipment lead clinching operation does not stress the capacitor leads where they enter the seal of the capacitor.

For chip type capacitors, excessive mounting pressure can cause high leakage current, short circuit, or disconnection.

#### 2.3 Manual Soldering

- (1) Observe temperature and time soldering specifications or do not exceed temperatures of 400 °C for 3 seconds or less.
- (2) If lead wires must be formed to meet terminal board hole spacing, avoid stress on the lead wire where it enters the capacitor seal.
- (3) If a soldered capacitor must be removed and reinserted, avoid excessive stress to the capacitor leads.
- (4) Avoid touching the tip of the soldering iron to the capacitor, to prevent melting of the vinyl sleeve.

#### 2.4 Flow Soldering

- (1) Do not immerse the capacitor body into the solder bath as excessive internal pressure could result.
- (2) Observe proper soldering conditions (temperature, time, etc.) Do not exceed the specified limits.
- (3) Do not allow other parts or components to touch the capacitor during soldering.

#### 2.5 Other Soldering Considerations

Rapid temperature rises during the preheat operation and resin bonding operation can cause cracking of the capacitor vinyl sleeve. For heat curing, do not exceed 150°C for a maximum time of 2 minutes.

Version 01 Page 13	
--------------------	--

### ELECTROLYTIC CAPACITOR SPECIFICATION SK SERIES

# **SAMXON**

- 2.6 Capacitor Handling after Solder
- (1). Avoid movement of the capacitor after soldering to prevent excessive stress on the lead wires where they enter the seal.
- (2). Do not use capacitor as a handle when moving the circuit board assembly.
- (3). Avoid striking the capacitor after assembly to prevent failure due to excessive shock.

#### 2.7 Circuit Board Cleaning

- (1) Circuit boards can be immersed or ultrasonically cleaned using suitable cleaning solvents for up 5 minutes and up to 60°C maximum temperatures. The boards should be thoroughly rinsed and dried. The use of ozone depleting cleaning agents is not recommended in the interest of protecting the environment.
- (2) Avoid using the following solvent groups unless specifically allowed for in the specification;

Halogenated cleaning solvents: except for solvent resistant capacitor types, halogenated solvents can permeate the seal and cause internal capacitor corrosion and failure. For solvent resistant capacitors, carefully follow the temperature and time requirements of the specification. 1-1-1 trichloroethane should never be used on any aluminum electrolytic capacitor.

Alkali solvents : could attack and dissolve the aluminum case.

Petroleum based solvents: deterioration of the rubber seal could result.

Xylene : deterioration of the rubber seal could result.

Acetone : removal of the ink markings on the vinyl sleeve could result.

- (3) A thorough drying after cleaning is required to remove residual cleaning solvents which may be trapped between the capacitor and the circuit board. Avoid drying temperatures, which exceed the maximum rated temperature of the capacitor.
- (4) Monitor the contamination levels of the cleaning solvents during use by electrical conductivity, pH, specific gravity, or water content. Chlorine levels can rise with contamination and adversely affect the performance of the capacitor. Please consult us for additional information about acceptable cleaning solvents or cleaning methods.

#### 2.8 Mounting Adhesives and Coating Agents

When using mounting adhesives or coating agents to control humidity, avoid using materials containing halogenated solvents. Also, avoid the use of chloroprene based polymers. After applying adhesives or coatings, dry thoroughly to prevent residual solvents from being trapped between the capacitor and the circuit board.

#### 3. Precautions for using capacitors

3.1 Environmental Conditions

Capacitors should not be stored or used in the following environments.

- (1) Temperature exposure above the maximum rated or below the minimum rated temperature of the capacitor.
- (2) Direct contact with water, salt water, or oil.
- (3) High humidity conditions where water could condense on the capacitor.
- (4) Exposure to toxic gases such as hydrogen sulfide, sulfuric acid, nitric acid chlorine, or ammonia.
- (5) Exposure to ozone, radiation, or ultraviolet rays.
- (6) Vibration and shock conditions exceeding specified requirements.

#### 3.2 Electrical Precautions

- (1) Avoid touching the terminals of the capacitor as possible electric shock could result. The exposed aluminum case is not insulated and could also cause electric shock if touched.
- (2) Avoid short circuit the area between the capacitor terminals with conductive materials including liquids such as acids or alkaline solutions.

#### 4. Emergency Procedures

- (1) If the pressure relief vent of the capacitor operates, immediately turn off the equipment and disconnect form the power source. This will minimize additional damage caused by the vaporizing electrolyte.

If electrolyte or gas enters the eye, immediately flush the eyes with large amounts of water.

If electrolyte or gas is ingested by month, gargle with water.

If electrolyte contacts the skin, wash with soap and water.

#### 5. Long Term Storage

Leakage current of a capacitor increases with long storage times. The aluminum oxide film deteriorates as a function of temperature and time. If used without reconditioning, an abnormally high current will be required to restore the oxide film. This current surge could cause the circuit or the capacitor to fail. After one year, a capacitor should be reconditioned by applying rated voltage in series with a  $1000\Omega$ , current limiting resistor for a time period of 30 minutes . If the expired date of products date code is over eighteen months, the products should be return to confirmation.

#### 5.1 Environmental Conditions

Version 01 Page 14	
--------------------	--

# ELECTROLYTIC CAPACITOR SPECIFICATION SK SERIES

# **SAMXON**

The capacitor shall be not use in the following condition:

- (1) Temperature exposure above the maximum rated or below the minimum rated temperature of the capacitor.
- (2) Direct contact with water, salt water, or oil.
- (3) High humidity conditions where water could condense on the capacitor.
- (4) Exposure to toxic gases such as hydrogen sulfide, sulfuric acid, nitric acid, chlorine, or ammonia.
- (5) Exposure to ozone, radiation, or ultraviolet rays.
- (6) Vibration and shock conditions exceeding specified requirements.

#### 6. Capacitor Disposal

When disposing of capacitors, use one of the following methods.

Incinerate after crushing the capacitor or puncturing the can wall (to prevent explosion due to internal pressure rise). Capacitors should be incinerated at high temperatures to prevent the release of toxic gases such as chlorine from the polyvinyl chloride sleeve, etc.

Dispose of as solid waste.

NOTE: Local laws may have specific disposal requirements, which must be followed.

	0.4	_	
Version	01	Page	15